## Search Notes



Applica	ation	/Contro	ol No
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10590632

Applicant(s)/Patent Under Reexamination

JENSEN ET AL.

Examiner

**Art Unit** 

Young J Kim

1637

## **SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES**

Search Notes	Date	Examiner
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	9/15/2008	/YJK/
see enclosed for text-search strategy	9/15/2008	/YJK/
updated - patent databases search - see enclosed for text-search strategy	5/13/2009	/YJK/

INTER	FEREN	ICE SE	ARCH

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/Young J Kim/ Primary Examiner.Art Unit 1637

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